Sub-µm axial precision depth imaging with entangled two-colour Hong-Ou-Mandel microscopy

Cyril Torre^{1,2}, Alex McMillan¹, Jorge Monroy-Ruz¹ and Jonathan C.F. Matthews¹

1. Quantum Engineering Technology Labs, H. H. Wills Physics

Laboratory and Department of Electrical & Electronic Engineering,

University of Bristol, Tyndall Avenue, BS8 1FD, United Kingdom. and

2. Quantum Engineering Centre for Doctoral Training,

H. H. Wills Physics Laboratory and Department of Electrical & Electronic Engineering,

University of Bristol, Tyndall Avenue, BS8 1FD, United Kingdom

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The quantum interference of two wavelength-entangled photons overlapping at a beamsplitter results in an oscillating interference pattern. The frequency of this interference pattern is dependent on the wavelength separation of the entangled photons, but is robust to wavelength scale perturbations that can limit the practicality of standard interferometry. Here we use two-colour entanglement interferometry to demonstrate 3D imaging of a semi-transparent sample with sub- μm precision. The axial precision and the dynamic range of the microscope is actively controlled by detuning the wavelength separation of the entangled photon pairs. Sub- μm precision is reported using up to 16 nm of detuning with ~ 10³ photon pairs for each pixel.

The Hong-Ou-Mandel (HOM) interference effect is routinely used in quantum photonics, for example to generate NOON states for quantum enhanced interferometry [1] and imaging [2, 3], for photonic two-qubit quantum logic gates [4–6] and it is the underpinning physical phenomena of optical quantum computational advantage experiments [7]. It is typically observed when two photons in separate temporal modes, but are otherwise indistinguishable, are made to overlap at a beamsplitter (Fig. 1). As the relative arrival time t of the two photons is reduced to zero, the detection rate of the photons exiting the beamsplitter separately (anti-bunching) ideally drops to zero, while the detection events of photons outputting together (bunching) increases. This can be used to measure a relative optical path length that induces t, which was demonstrated to subpicosecond precision in the seminal experiment by Hong, Ou and Mandel [8].

By utilising the HOM effect for imaging and sensing (Fig. 1(iv)), more recent demonstrations have extracted higher sensitivities to measure t with attosecond precision [9], for polarisation measurements [10], spectroscopy [11], multi-mode depth imaging [12] and refractive index measurement [13]. In these works, Fisher Information $(\mathcal{F}(t))$ and the Cramér Rao bound (CRB) $(\sigma_t^2 \ge 1/\mathcal{F}(t))$ quantify the maximum achievable precision σ_t for an unbiased estimator measuring t. $\mathcal{F}(t)$ can be modelled from analytic probability functions $P_i(t)$ for each outcome (i) using

$$\mathcal{F}(t) = \sum_{i=1}^{n} \frac{1}{P_i(t)} \left(\frac{\partial P_i(t)}{\partial t}\right)^2, \qquad (1)$$

which highlights dependence on the shape of the interference features given by $P_i(t)$. For degenerate photons, $\mathcal{F}(t)$ can be increased by broadening the photon spectrum to yield steeper HOM interference features [9]. However, increasing the bandwidth of photons leads to a tradeoff between measurement precision and dynamic

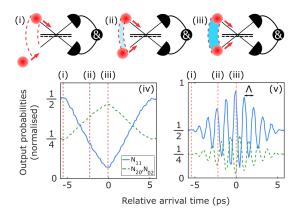


Figure 1. HOM interference for degenerate and twocolour entangled photons. (i-iii) Photon pairs incident on a beamsplitter with zero (i), partial (ii) and complete (iii) temporal overlap. Typical resulting HOM interference patterns for degenerate (iv) and two-colour entangled photons (v) are plotted, showing bunching (N_{20} , N_{02} — green dashed) and anti-bunching (N_{11} — blue) rates. Overlap conditions corresponding to cases (i-iii) are highlighted. The wavelength of the oscillating interference fringe Λ (marked on (v)) is directly controlled by the frequency detuning ($\Delta \nu = 1/\Lambda$) of signal and idler wavelengths.

range, while highly broadband photons can also lead to dispersion in the apparatus optics.

An alternative to increase HOM inteferometer sensitivity is to use the two-colour entangled state [14, 15]

$$|\Psi\rangle = \frac{1}{\sqrt{2}} \left(|\nu_S\rangle_{\mathcal{A}} |\nu_I\rangle_{\mathcal{B}} + e^{i\phi(t)} |\nu_I\rangle_{\mathcal{A}} |\nu_S\rangle_{\mathcal{B}} \right), \quad (2)$$

where ν_S and ν_I label frequencies of the signal and idler photons, while \mathcal{A} and \mathcal{B} denote the two separate optical paths that will overlap at a beamsplitter. The resulting two-photon interference of $|\Psi\rangle$ exhibits a beat note with a frequency $\Delta \nu = \nu_S - \nu_I$ that is dependent on the spectral detuning of signal and idler [14]. This approach has been shown to directly modify $\mathcal{F}(t)$ and has been applied to detect temperature drifts in optical fibre [15]. To apply two-colour HOM interferometry to 3D imaging we construct a tunable wavelength-entangled photon pair source and combine this with both a raster-scanning microscope inside of a HOM interferometer and a quasiphoton number resolving detection scheme [16].

The target entangled state in Eq. (2) is generated using a dual-Sagnac arrangement source that needs only one nonlinear down-conversion crystal, as shown in Fig. (2i). A diagonally polarised CW 404 nm laser is split into two paths by a polarising beam-splitter (PBS) pumping one 3 cm long, type-II periodically poled potassium titanyl phosphate (ppKTP) crystal from two directions. Downconverted photon pairs centred at 808 nm are emitted from the ppKTP crystal in each direction, separated from the pump using shortpass dichroic mirrors (DMS) and subsequently interfere on a second PBS. The spatial mode is filtered with single-mode fibres at the output paths \mathcal{A} and \mathcal{B} .

As the generated photons in the system do not share a common path, the source is susceptible to phase instability of the parameter $\phi(t)$ in the intended output entangled state Eq. (2) due to mechanical vibrations and temperature variations (in contrast to standard polarisation entangled photon pair sources based on a single Sagnac interferometer [17, 18]). We therefore actively stabilise the setup using a diagonally polarised laser at the cut-off wavelength of the DMS (where these are only partially reflective) that is back-propagated through the source optics and monitored with fast balanced photodiodes detectors. The subtracted electric signal from the photodiodes is sent to a PID controller that actuates a piezo stack glued to the mirror of the clockwise pumping path.

The detuning of the central frequencies of the downconverted photons is readily controlled through phasematching conditions, which in turn can be tuned by changing the crystal temperature whilst leaving the pump laser frequency unchanged. The temperature of the crystal can be set from $30^{\circ}C$ to $180^{\circ}C$ achieving a detuning from 0 to $30.1 \ THz$ (65.6 nm) (see Supplementary Information). The photon pair source generates $\sim 200 \ k$ measured coincidences per second with an input pump power of $\sim 20 \ mW$ and we observe a symmetric heralding efficiency up to 25% at the positions marked \mathcal{A} and \mathcal{B} in Fig. (2i).

The schematic of the confocal microscope is illustrated in Fig. (2ii). A semi-transparent sample (with a thickness d and refractive index n) is mounted between two lenses in a confocal configuration in path \mathcal{D} , before the broadband 50:50 beamsplitter (BS) where the HOM interference occurs. The presence of the sample introduces an additional time delay between paths \mathcal{C} and \mathcal{D} related to the optical path length by t = nd/c. This changes the degree of indistinguishability between the two photons and consequently the relative number of anti-bunching

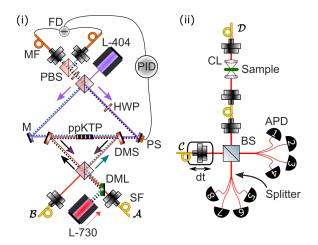


Figure 2. Schematic of the wavelength-entangled photon pair source and HOM microscope. (i) Wavelengthentangled photon pair source, comprising: a 404 nm CW pump laser (L-404), polarising beamsplitter (PBS), mirror (M), half waveplate (HWP), periodically poled KTP crystal (ppKTP), piezo-actuated mirror (PS), shortpass dichroic mirrors (DMS), longpass dichroic mirrors (DML), feedback controller (PID), fast balanced photodiodes detectors (FD), single mode fibre (SF), multimode fibre (MF) and a CW laser at 730 nm to phase lock the source (L-730). \mathcal{A} and \mathcal{B} denote the two output modes from Eq (2). (ii) The HOM microscope, comprising lenses with focal length f = 11 mm in a confocal configuration (CL), beamsplitter (BS), 1×4 fused fibre coupler (Splitter), time delay for one input beam controlled by a translation stage (dt) and avalanche photodiode detectors (APD). C and D denote the input port of the interferometer. Any coincidences between one detector labelled amongst 1 to 4 with one detector labelled amongst 5 to 8 contribute to N_{11} , while any coincidences between pairs of detectors amongst 1 to 4 correspond to N_{02} and coincidences between pairs of detectors amongst 5 to 8 give N_{20} . This quasi-photon number resolving detection scheme adds an intrinsic loss of 25% for the bunching terms.

events (N_{11}) detected due to the HOM interference effect [12]. Depth features of the sample can also cause path-deviation of the probe photons, thereby altering the spatial overlap of the signal and idler modes at the BS. This reduces the visibility of the HOM interference leading to an error in the observed bunching rate and consequently in the sample thickness estimation. In our experiment we implement single-mode, raster-scanned imaging by translating the sample whilst keeping the probe beam fixed. A single mode fibre after the sample implements spatial mode filtering and ensures a constant overlap of the two spatial modes at the BS. Any change in detected coincidence rates due to the path-deviation or fluctuations in source brightness is normalised through the bunching events (N_{20} and N_{02}) according to

$$P_{11} = \frac{\tilde{N}_{11}}{\tilde{N}_{11} + \tilde{N}_{02} + \tilde{N}_{20}},\tag{3}$$

where \widetilde{N}_{11} , \widetilde{N}_{02} , and \widetilde{N}_{20} are calibrated via the Klyshko

efficiency [19] (see Supplementary Information). These values are all dependent on the HOM interference effect and are individually monitored with quasi-photon number resolving detection scheme using multiplexed single photon detectors [20, 21] as shown in Fig. (2ii). The detectors are silicon single photon avalanche photodiode modules (APD; Excelitas) and the coincidences between them are recorded with a Logic16 time-tagger (UQDevices).

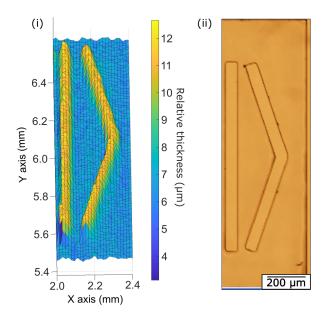


Figure 3. **3D sample imaging.** (i) 3D HOM imaging by monitoring the number of coincidences for each pixel. Raster scanning of the sample through the single-mode illumination provides the spatial resolution in the 2D transverse plane. The acquisition time is 0.5 s for each pixel $(N \sim 4000)$. The frequency beat note is 7.4 THz, where the detuning is chosen such that the characteristic depth features of this sample correspond to measurements across the full range of half of a fringe period from the HOM interference. This attains the maximum Fisher information while avoiding fringe ambiguity. (ii) 2D conventional optical microscope image of the sample.

The transverse resolution of the microscope is limited by the beam waist of the scanning probe, whilst the axial resolution, which is the focus of this work, is given by the frequency of the beat note arising in the HOM interference. To maximise the Fisher information for the depth estimate whilst keeping all of the measurements within the same interference fringe half-period (avoiding fringe ambiguity), the signal and the idler photons were detuned by 7.4 THz (16 nm) giving a beat note with a half-period $\Lambda/2 = 20.3 \ \mu m$. For comparison to a classical linear optics approach, performing classical interferometry with an equivalent sensitivity would require an electromagnetic radiation source with a central wavelength of $\sim 40 \ \mu m$, together with compatible optics and detection. Operating at such a wavelength would constrain the transverse spatial resolution due to the diffraction limit.

A test sample for imaging was fabricated by deposit-

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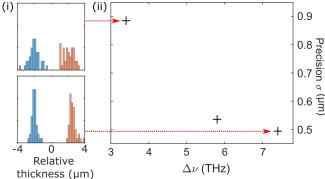


Figure 4. Axial precision for varying beat note frequency. (i) Histograms of the axial depth estimate for the two step measurement for beat note frequencies of 3.4 and 7.4 THz. (ii) Precision of depth estimation calculated from the raw histogram data using Eq. (4).

ing micron-scale SU-8 polymer features with a thickness $\sim 5 \ \mu m$ onto a silica substrate in the shape of a "KET" symbol (shown in Fig. (3.ii)). A 3D image of this sample is shown in Fig. (3.i). 27×78 pixel positions were measured by monitoring the outcomes of the HOM interferometer, with data acquisition time $\sim 20 \min (\sim 40 \min$ total measurement time due to the limited speed of the translation stages) for an area of $0.4 mm^2$. The maximum transverse resolution of the HOM microscope was determined to be $\sim 5 \times 5 \ \mu m^2$ with a resolution test target, but due to the size of this sample, a reduced transverse resolution (~ $15 \times 15 \ \mu m^2$) was used to decrease the total acquisition time. Assuming the known refractive index value for this polymer to be n = 1.58, the measured relative thickness between the two steps in this sample is determined to be $4.6 \pm 0.5 \ \mu m$.

Fig. (4) shows the results of repeated measurements of the sample for different beat note frequencies, which was used to characterise the axial precision. For each parameter combination, half of the pixels corresponded to positions on the deposited polymer, which we denote as step 1 (S_1) , while the other half correspond to positions on the substrate where no polymer was deposited, denoted as step 2 (S_2) . As the depth estimates for the two regions are statistically independent, the overall precision combining the two data sets is given by

$$\sigma_t = \sqrt{var(S_1) + var(S_2)}.$$
(4)

Fig (4.i) shows examples of the underlying histogram results of the measured depth for two of the data points in Fig (4.ii). The effect of increasing $\Delta \nu$ is evident from the reduced variance of the data set of S_1 and S_2 arising from the increase in the Fisher information. Consequently the precision of the measurements is improved and smaller depth features can be more easily distinguished. The best precision result of 0.5 μm demonstrates depth estimation on a shorter scale than the central wavelength of the probe photons.

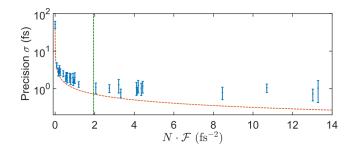


Figure 5. Axial precision for single pixel estimation. Axial precision (y axis) for different total of Fisher information (x axis) by varying the frequency of the beat note. The acquisition time is fixed to 0.5 s and the number of photon pairs to $N \sim 10^4$ for every data points. The Fisher information is calculated using Eq. (1). Each blue point on the graph corresponds to 500 independent time delay measurements split into blocks of 50, where the mean of the standard deviation of these blocks corresponds to the precision. The standard deviation from these 10 blocks gives the error bars. The dashed orange line corresponds to the theoretical bound of the precision for N photons following the Cramér Rao bound (CRB), and the dashed green line corresponds to the maximum value of $N \cdot \mathcal{F}$ which can be achieved under the same parameters as Fig. (3i).

In order to decouple thickness variation in the sample from the performance of the microscope, repeated measurements were performed on a single pixel and the results are shown in Fig. (5). In our lab the measurements were stable over a time period of $\sim 30 \ min$ and drift in the phase occurred over longer periods of time, which resulted from mode-hopping instability of the laser used to phase-lock the source. Changes in the output wavelength of the reference laser lead to fluctuations in the phase-locking conditions in the interferometer and drifts in the depth estimation. We also observe that as the Fisher information increases, the measured precision deviates from the CRB. We believe that this is due to an additional phase-locking instability observed at high crystal temperatures ($\geq 120 \ ^{\circ}C$). Two-colour photon pair sources designed to be more robust to phase instability may provide an improvement in the saturation of

the CRB for higher frequency beat notes [15].

Using Eq.(4), it can be shown that $\operatorname{sub-}\mu m$ precision can be achieved for a measurement with total Fisher information $(N \cdot \mathcal{F})$ of 0.2 fs^{-2} when the CRB is saturated. Comparing this value to Fig. (5), this could be achieved with a detuning of 16 nm and $N \sim 400$ photon pairs detected, which corresponds to the same experimental parameters from Fig. (3i) with an acquisition time of $dt = 0.05 \ s$. This could be achieved with faster raster-scanning techniques.

The total loss in the source and the microscope was relatively high ($\sim 98\%$ for each photon). This included $6 \, dB$ of loss for FC to FC fibre connectors, which could be removed. This limited the total amount of Fisher information by reducing the number of detected probe photons for a given acquisition time. Reducing the loss and optimising the brightness of the source could improve the axial resolution by an order of magnitude. To increase the precision further on more complex samples with greater thickness variations, whilst avoiding fringe ambiguity, one could perform an initial coarse mapping of the depth profile using raster-scanning with a low frequency beat note, followed by a scan at increased resolution with a larger wavelength detuning. High resolution scanning could also be reserved for targeted areas of interest to reduce the required measurement time.

We have shown that HOM interference can be implemented with two-colour entangled photon pairs to achieve 3D imaging with sub- μm precision for depth estimation. Measurement techniques of this type could be particularly relevant for characterising in situ, subcellular structures for semi-transparent samples such as biological cells.

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I. SUPPLEMENTARY INFORMATION

A. Hong-Ou-Mandel for two-colour state

With a type-II crystal and unfiltered, degenerate photon pair source, the probability of the anti-bunching state at the output from the HOM interferometer is given by [22]:

$$P_{11}(t) = \frac{1}{2} \left[1 - \alpha \left(1 - \left| \frac{2t}{\tau} \right| \right) \right], \text{ for } \left| \frac{2t}{\tau} \right| \le 1, \quad (5)$$

where α is the visibility of the HOM interference, τ is the temporal width of the photons, and t is the relative time delay between the two interfering photons. To model the HOM interference of the two-colour entangled photons given by:

$$|\Psi\rangle = \frac{1}{\sqrt{2}} \left(|\nu_S\rangle_{\mathcal{A}} |\nu_I\rangle_{\mathcal{B}} + e^{i\phi(t)} |\nu_I\rangle_{\mathcal{A}} |\nu_S\rangle_{\mathcal{B}} \right), \quad (6)$$

we multiply the term $\alpha (1 - |2t/\tau|)$ from Eq. (5) by an additional term $\cos(2\pi\Delta\nu\tau + \phi(t))$ giving

$$P_{11}(t) = \frac{1}{2} \left[1 - \alpha \left(1 - \left| \frac{2t}{\tau} \right| \right) \cos(2\pi \Delta \nu \tau + \phi(t)) \right].$$
(7)

 $\Delta \nu = \nu_S - \nu_I$ is the frequency detuning between the signal and the idler and $\phi(t)$ is the relative phase between the two sub-states from Eq.(6). Due to conservation of energy, the probability of the bunching terms N_{02} and N_{20} is given in the ideal case by:

$$P_{20} = P_{02} = \frac{1 - P_{11}}{2}.$$
 (8)

B. Calibration with the use of Klyshko efficiency

The calibration of N_{11} , N_{20} and N_{02} is implemented through the Klyshko efficiency [19]. We utilise the measured anti-bunching rate at a sufficiently large time delay to avoid HOM interference and define η_i to be the Klyshko efficiency of the i^{th} channel (i = 1, 2, 3, 4),

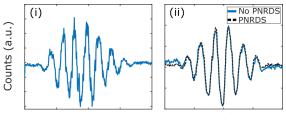
$$\eta_i = \frac{1}{4} \sum_{j=5}^{8} \frac{C_{ij}}{2/3 \cdot Sj}.$$
(9)

 C_{ij} are the raw coincidence counts between the detectors i and j. S_j corresponds to the single counts detected by detector j (j = 5, 6, 7, 8). With $P_{11} = \frac{1}{2} = 2 \times P_{20} = 2 \times P_{02}$, only $\frac{2}{3}$ of the single counts from the detectors j will correspond to the state N_{11} while $\frac{1}{3}$ of these single counts belong to the anti-bunching state N_{20} . Likewise, similar expressions can be derived for the other detector channels, where the roles of i and j are reversed. Finally,

each coincidence count total C_{ij} can be normalised using the corresponding heralding efficiency coefficients to account for unbalanced losses.

C. Experimental characterisations

The wavelength-entangled photon pair source has to be actively phase-locked to remove instability in the HOM interference, which otherwise results in noise in the measurement as shown in Fig. (6.i). In order to distinguish between changes in the brightness of the source and changes in the loss or bunching rate induced by the sample, the use of quasi-photon number resolving detection scheme (PNRDS) allows the bunching and anti-bunching terms to be monitored independently, normalising the measurement. The effect of imbalanced alignment is apparent in Fig.(6.ii) from asymmetry in the baseline count rate on the extreme right-hand and left-hand sides of the image (blue line), and is corrected by the use of the PN-RDS (dashed black line).



Relative arrival time (a.u.)

Figure 6. Example of HOM interference stabilisation. (i) No phase-locking or normalisation, (ii) phase-locking and no normalisation (blue), phase-locking and normalisation with the use of PNRDS (dashed black).

Fig. (7) shows characterisation data for the frequency detuning between the signal and the idler of the photon pair source. The central wavelengths of the signal and idler peaks were measured with a sensitive, high resolution spectrometer (Andor, SR-750-B2-R-SIL) for a range of crystal temperatures. The pump laser wavelength was measured to be $\lambda_p = 404.093 \ nm$ with a linewidth of $\Delta \lambda_p = 0.05 \ nm$, close to the resolution limit of the spectrometer. As shown in Fig. (7), the detuning values predicted using the HOM interference beat note show good agreement with the calibrated detuning curve measured using the spectrometer.

D. Sample preparation

The fabricated semi-transparent sample consisted of a 1 mm thick fused silica substrate where a ~ 5 μm thick film of SU-8 polymer was deposited by spin-coating. SU-8 is a negative epoxy photoresist with a high optical transparency making it ideal for this work. Using photolithography, an image of a "KET" was transferred to the polymer, resulting in a semi-transparent sample with two different steps.

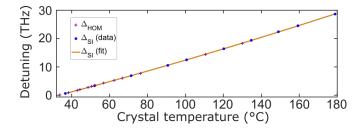


Figure 7. Detuning of the photon pair. Blue data points are the experimentally measured values for detuning of the signal and idler peaks at different crystal temperatures. $\Delta \nu_{SI}$ (yellow line) is a quadratic fit to these data points. $\Delta \nu_{HOM}$ (purple crosses) shows expected values for the signal and idler detuning. These were calculated using Eq.(7) from the frequency of the beat note of a measured HOM dip at each corresponding crystal temperature.